

Search Notes

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10/711,070

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

REYES ET AL.

Art Unit

2636

SEARCHED

Class	Subclass	Date	Examiner
340	572.1	1/18/2006	JAT
	572.5	1/18/2006	JAT
	10.1	1/18/2006	JAT
73	81	1/18/2006	JAT
	84	1/18/2006	JAT
	182	1/18/2006	JAT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR